

Monolithic Amplifier

PHA-102+

 50Ω 50 MHz to 6 GHz

THE BIG DEAL

- Ultra Wideband, 50 MHz to 6 GHz
- Excellent gain flatness 14.3 ± 0.3 dB from 0.05-3 GHz
- High Linearity, +26.4 dBm P1dB & +50 dBm OIP3 at 0.9 GHz
- May be used as a replacement for AH102^{a,b}



Generic photo used for illustration purposes only CASE STYLE: DF782

+RoHS Compliant
The +Suffix identifies RoHS Compliance.
se our website for methodologies and qualifications

APPLICATIONS

- WiFi
- WLAN
- LTE
- WiMAX
- S-band Radar

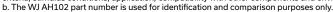
PRODUCT OVERVIEW

The PHA-102+ (RoHS compliant) is an advanced wideband amplifier fabricated using PHEMT technology and offers extremely high dynamic range over a broad frequency range and with excellent gain flatness. In addition, the PHA-102+ has good input and output return loss over a broad frequency range. PHA-102+ is enclosed in a SOT-89 package and has very good thermal performance.

KEY FEATURES

Feature	Advantages		
Ultra Wideband: 50MHz to 6GHz	Broadband covering primary wireless communications bands		
Extremely High IP3 +50 dBm typ. at 0.9 GHz +40.3 dBm typ. at 3 GHz	The PHA-102+ matches industry leading IP3 performance relative to device size and power consumption. The combination of the design and PHEMT Structure provides enhanced linearity over a broad frequency range as evidence in the IP3 being approxi- mately 17 dB above the P1dB point. This feature makes this amplifier ideal for use in: • Driver amplifiers for complex waveform up converter paths • Drivers in linearized transmit systems • Secondary amplifiers in ultra-High Dynamic range receivers		
Excellent Gain Flatness, 50 MHz-3GHz	Typical ±0.3 dB gain flatness across the entire frequency range minimizes the need for external equalizer networks making it a great fit for instrumentation and EW application.		

a. Suitability for model replacement within a particular system must be determined by and is solely the responsibility of the customer based on, among other things, electrical performance criteria, stimulus conditions, application, compatibility with other components and environmental conditions and stresses.







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50 MHz to 6 GHz 50Ω

ELECTRICAL SPECIFICATIONS AT +25°C, 50Ω, UNLESS NOTED OTHERWISE

Parameter	Condition	V_{DD} =+9 V^1			Vs=+9V ²	Unito	
Falanieter	(MHz)	Min.	Тур.	Max.	Тур.	Units	
Frequency Range		50		6000	50-6000	MHz	
	50	13.1	14.6	16.0	14.2		
	900	_	14.5	_	14.2		
Cain	2000	12.7	14.1	15.5	13.8	dB	
Gain	2500	_	14.0	_	13.7	ав	
	3000	12.5	14.0	15.3	13.8		
	6000	_	11.9	_	10.9		
Gain flatness (±)	50-3000		0.3		0.25	dB	
	50		14		12		
	900		14		13		
Local Balance Local	2000		12		13	ı.D	
Input Return Loss	2500		12		14	dB	
	3000		12		15		
	6000		4		4		
	50		18		13		
	900		17		17		
	2000		15		15		
Output Return Loss	2500		14		15	dB	
	3000		14		15		
	6000		4		4		
	50		+26.1		+25.4		
	900		+26.4		+26.0		
	2000		+26.5		+26.1		
Output Power @1dB compression	2500		+26.1		+25.6	dBm	
	3000		+25.6		+25.0		
	6000		+20.4		+19.8		
	50		+44.8		+41.6		
	900		+50.0		+49.3		
Output IP3	2000		+43.0		+42.5		
(Pout = 0dBm/Tone)	2500		+41.4		+41.4	dBm	
	3000		+40.3		+40.4		
	6000		+37.3		+38.1		
	50		3.6		3.6		
	900		3.4		3.6		
	2000		3.7		3.8		
Noise Figure	2500		3.7		3.7	dB	
	3000		4.0		4.0		
	6000		6.7		7.0		
Device Operating Voltage		+8.5	+9	+9.5	+9	V	
Device Operating Current		5.5	192	211	191	mA	
Device Current Variation vs. Temperature ³			57.69		57.69	μΑ/°C	
Device Current Variation vs. Voltage ⁴			0.026		0.026	mA/mV	
Thermal Resistance Junction-To-Ground Lead at 85°C stage temperature			20.4		20.4	°C/W	
merma nesistance sunction ro-distuitu Lead at 65 C stage temperature		I	20.4		20.4	C/ VV	

^{1.} Measured on Mini-Circuits Characterization Test Board. See Characterization Test Circuit (Figure 1A, 1B & 1C).

^{2.} Measured on Mini-Circuits Application Evaluation Board TB-PHA-102+. See Application Test Circuit (Figure 2).

^{3.} Device Current Variation vs. Temperature= (Current at 45° C)/130°C 4. Device Current Variation vs. Voltage = (Current at 4.5° C) - Current at 4.5° C)/($(9.5^{\circ}$ -8.5V)*1000 mV/V)



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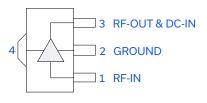
50Ω 50 MHz to 6 GHz

ABSOLUTE MAXIMUM RATINGS⁵

Parameter	Ratings		
Operating Temperature (ground lead)	-40°C to +85°C		
Storage Temperature	-65°C to +150°C		
Power Dissipation	3.18 W		
Input Power (CW)	+22 dBm (continuous) +25 dBm (5 minutes max)		
DC Voltage on Pin 3	+11 V		

^{5.} Permanent damage may occur if any of these limits are exceeded. Electrical maximum ratings are not intended for continuous normal operation.

SIMPLIFIED SCHEMATIC AND PIN DESCRIPTION



Function	Pin Number	Description
RF-IN	1	RF Input pin.
RF-OUT and DC-IN	3	RF Output and DC Bias
GND	Paddle	Connections to ground.

CHARACTERIZATION TEST CIRCUIT FOR S-PARAMETER & NOISE FIGURE MEASUREMENT

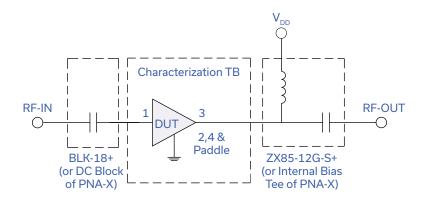


Fig 1A. Block Diagram of Test Circuit used for S-Parameter and Noise Figure Measurement. (DUT is soldered on Mini-Circuits Characterization test board.) Gain, Return loss and noise figure are measured using Agilent's N5242A PNA-X microwave network analyzer.

Conditions:

1. Gain and Return loss: P_{IN}= -25dBm



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CHARACTERIZATION TEST CIRCUIT FOR P1dB MEASUREMENT

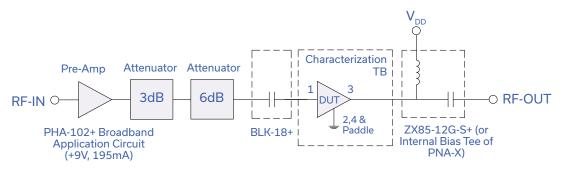


Fig 1B. Block Diagram of Test Circuit used for P1dB Measurement. (DUT is soldered on Mini-Circuits Characterization test board.) Output power at1dB compression is measured using Agilent's N5242A PNA-X microwave network analyzer.

CHARACTERIZATION TEST CIRCUIT FOR IP3 MEASUREMENT

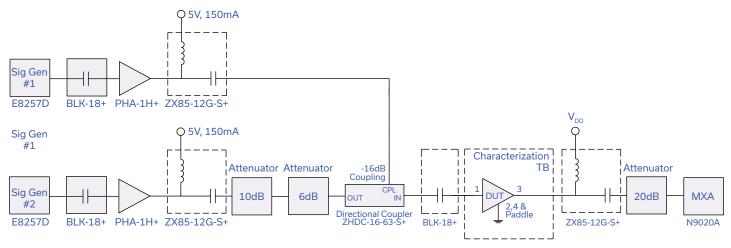


Fig 1C. Block Diagram of Test Circuit used for IP3 Measurement. (DUT is soldered on Mini-Circuits Characterization test board) P1dB is measured using two E8257D Signal Generators and one N9020A MXA Signal Analyzer.

Condition:

1. Output IP3 (OIP3): Two Tones spaced 1 MHz apart, 8 dBm/ tone at output.

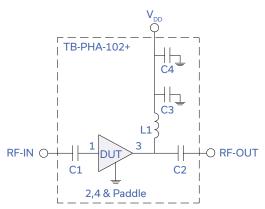


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50 MHz to 6 GHz 50Ω

APPLICATION TEST CIRCUIT



Component	Size	Value	Part Number	Manufacturer
	0402	1000pF	GRM1555C1H102JA01D	Murata
C2	0402	1000pF	GRM1555C1H102JA01D	Murata
C3	0402	100pF	GRM1555C1H101JA01D	Murata
C4	0402	10000pF	GRM155R71H103KA88D	Murata
L1	0603	390nH	LQW18CNR39J00D	Murata

Fig 2. Block Diagram of Test Circuit used for characterization. (DUT soldered on Mini-Circuits Application test board TB-PHA-102+) Gain, Return loss, Output power at1dB compression (P1dB), output IP3 (OIP3) and noise figure are measured per Figure 1A, 1B & 1C, except DC block BLK-18+ and Bias-Tee ZX85-12G-S+(or Internal Bias-Tee of PNA-X) are not required.

Conditions:

- 1. Gain and Return loss: P_{IN}= -25dBm 2. Output IP3 (OIP3): Two Tones spaced 1 MHz apart, 8 dBm/ tone at output.

PRODUCT MARKING



Marking may contain other features or characters for internal lot control



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500 50 MHz to 6 GHz

ADDITIONAL DETAILED TECHNICAL INFORMATION IS AVAILABLE ON OUR DASHBOARD. CLICK HERE

	Data Table
Performance Data	Swept Graphs
	S-Parameter (S2P Files) Data Set (.zip file)
Case Style	DF782 (SOT 89) Plastic package, exposed paddle lead finish: matte-tin
Tape & Reel Standard quantities available on reel	F55 7" reels with 20, 50, 100, 200, 500 or 1K devices
Suggested Layout for PCB Design	PL-670
Evaluation Board	TB-PHA-102+
Environmental Ratings	ENV008T1

ESD RATING

Human Body Model (HBM): Class 1A (250V) in accordance with ANSI/ESD STM 5.1 - 2001

NOTES

C. The parts covered by this specification document are subject to Mini-Circuits standard limited warranty and terms and conditions (collectively, "Standard Terms"); Purchasers of this part are entitled to the rights and benefits contained therein. For a full statement of the standard terms and the exclusive rights and remedies thereunder, please visit Mini-Circuits' website at www.minicircuits.com/terms/viewterm.html



A. Performance and quality attributes and conditions not expressly stated in this specification document are intended to be excluded and do not form a part of this specification document.

B. Electrical specifications and performance data contained in this specification document are based on Mini-Circuit's applicable established test performance criteria and measurement instructions.